

## Features

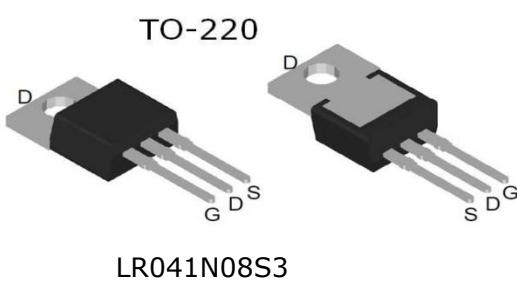
- Uses advanced SGT technology
- Extremely low on-resistance  $R_{DS(on)}$
- Excellent gate charge x  $R_{DS(on)}$  product(FOM)

## Application

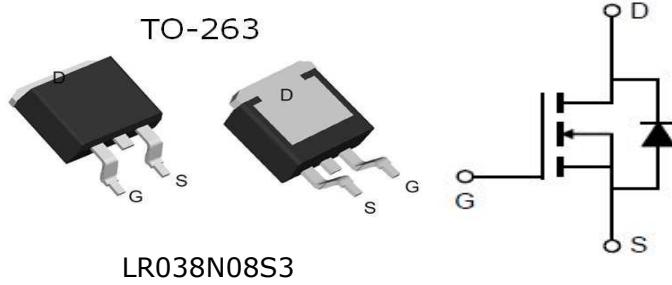
- Motor control and drives
- Battery management
- DC/DC converter
- General purpose applications

## Product Summary

	TO-220	TO-263
$V_{DS}$	80V	80V
$R_{DS(on)}@VGS=10V$	3.1mΩ	2.9mΩ
$I_D$	120A	120A



LR041N08S3



LR038N08S3

## Package Marking and Ordering Information

Type	Package	Marking	Reel Size	Tape Width	Packing	Qty
LR041N08SA3	TO-220	LR041N08SA3	-	-	Tube	50
LR038N08SA2	TO-263	LR038N08SA2	330*28.5mm	24mm	Reel&tape	800

## Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	80	V
Continuous drain current $T_C = 25^\circ C$ (Silicon limit) $T_C = 25^\circ C$ (Package limit) $T_C = 100^\circ C$ (Silicon limit)	$I_D$	170 120 109	A
Pulsed drain current $T_C = 25^\circ C$ , $t_p$ limited by $T_{jmax}$	$I_{D\ pulse}$	480	
Avalanche energy, single pulse ( $L=0.5mH, R_g=25\Omega$ )	$E_{AS}$	1040	mJ
Gate-Source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_C = 25^\circ C$	$P_D$	208	W
Operating junction and storage temperature	$T_j, T_{stg}$	-55~150	°C

**Thermal Resistance**

	<b>Symbol</b>	<b>Value</b>	<b>Unit</b>
Thermal resistance, junction – case. Max	$R_{thJC}$	0.60	°C/W
Thermal resistance, junction – ambient. Max	$R_{thJA}$	53	

**Electrical Characteristic, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

<b>Parameter</b>	<b>Symbol</b>	<b>Test Condition</b>	<b>Value</b>			<b>Unit</b>
			<b>min.</b>	<b>typ.</b>	<b>max.</b>	

**Static Characteristic**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	80	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$ $T_j=25^\circ\text{C}$	2	3	4	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=80\text{V}, V_{GS}=0\text{V}$ $T_j=25^\circ\text{C}$	-	-	1	$\mu\text{A}$
		$V_{DS}=64\text{V}, T_j=125^\circ\text{C}$	-	-	10	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=20\text{V}, V_{DS}=0\text{V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}, I_D=50\text{A},$ $T_j=25^\circ\text{C}$ TO-220 TO-263	-	3.1 2.9	4.1 3.8	mΩ
Transconductance	$g_{fs}$	$V_{DS}=5\text{V}, I_D=40\text{A}$	-	113	-	S

**Dynamic Characteristic**

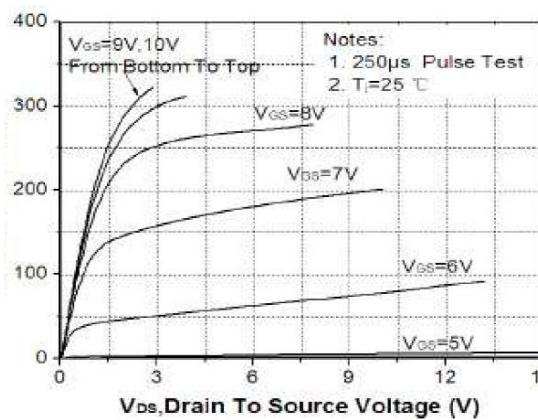
Input Capacitance	$C_{iss}$	$V_{GS}=0\text{V}, V_{DS}=40\text{V}, f=1\text{MHz}$	-	6050	-	pF
Output Capacitance	$C_{oss}$		-	1480	-	
Reverse Transfer Capacitance	$C_{rss}$		-	35	-	
Gate Total Charge	$Q_G$	$V_{GS}=10\text{V}, V_{DS}=40\text{V}, I_D=50\text{A}$	-	74	-	nC
Gate-Source charge	$Q_{gs}$		-	23	-	
Gate-Drain charge	$Q_{gd}$		-	21	-	
Turn-on delay time	$t_{d(on)}$	$T_j=25^\circ\text{C}, V_{GS}=10\text{V}, V_{DS}=40\text{V}, R_L=3\Omega$	-	32	-	ns
Rise time	$t_r$		-	53	-	
Turn-off delay time	$t_{d(off)}$		-	59	-	
Fall time	$t_f$		-	34	-	
Gate resistance	$R_G$	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	-	3.3	-	Ω

**Body Diode Characteristic**

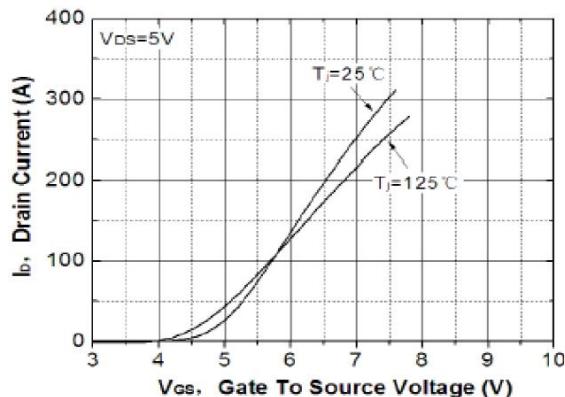
Body Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_{SD}=50A$	-	0.9	1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F=30A,$ $dI/dt=500A/\mu s$	-	78	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$I_F=30A,$ $dI/dt=500A/\mu s$	-	97	-	nC

## Typical Performance Characteristics

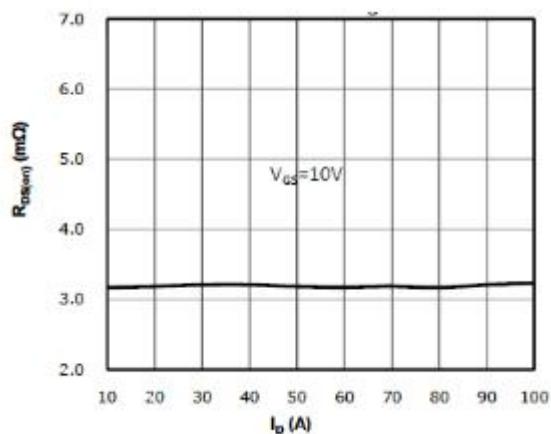
**Figure 1. Typ. Output Characteristics ( $T_j=25^\circ\text{C}$ )**



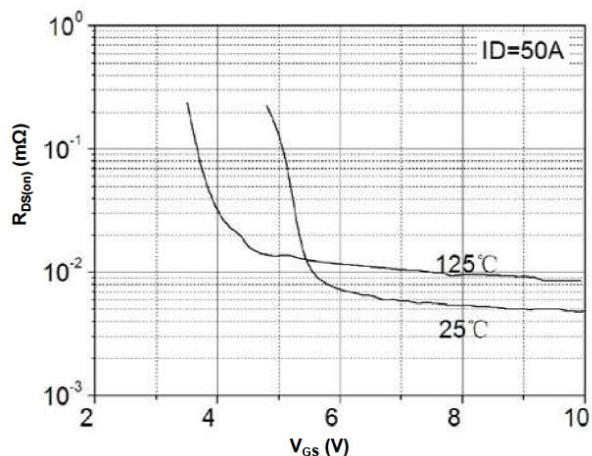
**Figure 2. Transfer Characteristics (Junction Temperature)**



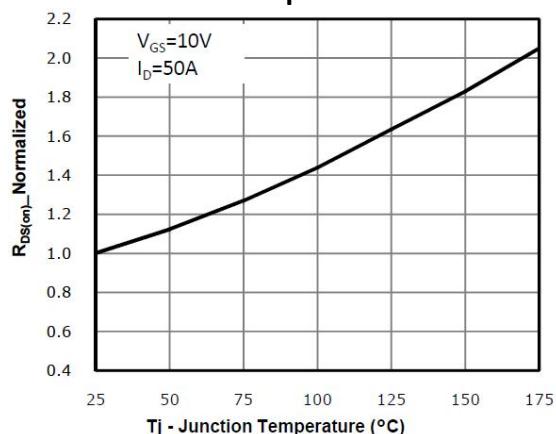
**Figure 3. On-Resistance vs. Drain Current Junction and Gate Voltage Figure**



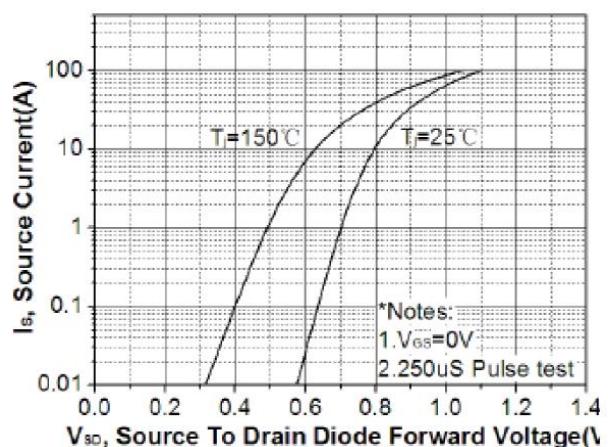
**Figure 5. On-Resistance vs. Gate-Source Voltage (Junction Temperature)**



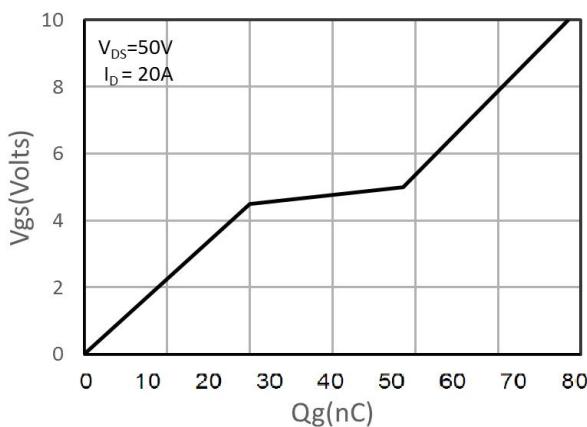
**Figure 4. On-Resistance vs. Temperature**



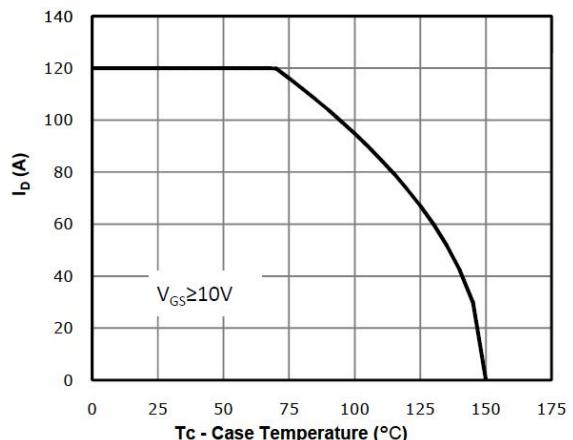
**Figure 6. Body-Diode Characteristics (Junction Temperature)**



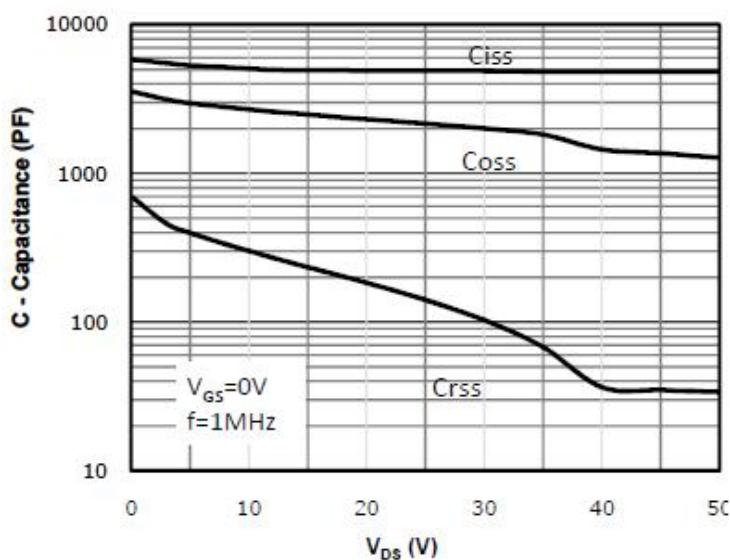
**Figure 7. Gate-Charge Characteristics**



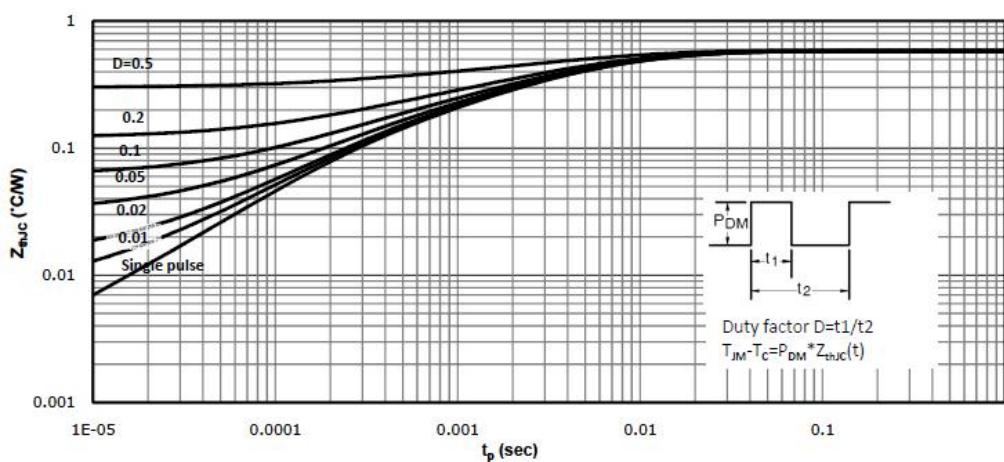
**Figure 8. Drain Current Derating**



**Figure 9. Capacitance Characteristics**

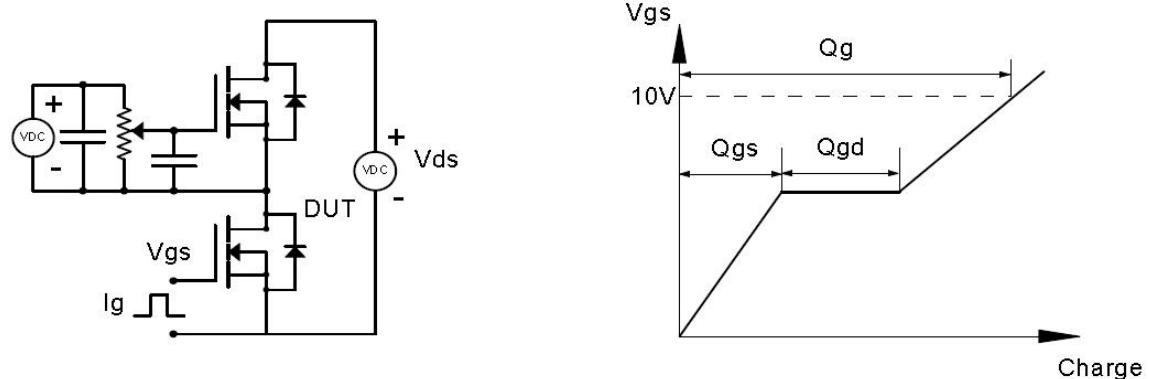


**Figure 10. Normalized Maximum Transient Thermal Impedance ( $R_{thJC}$ )**

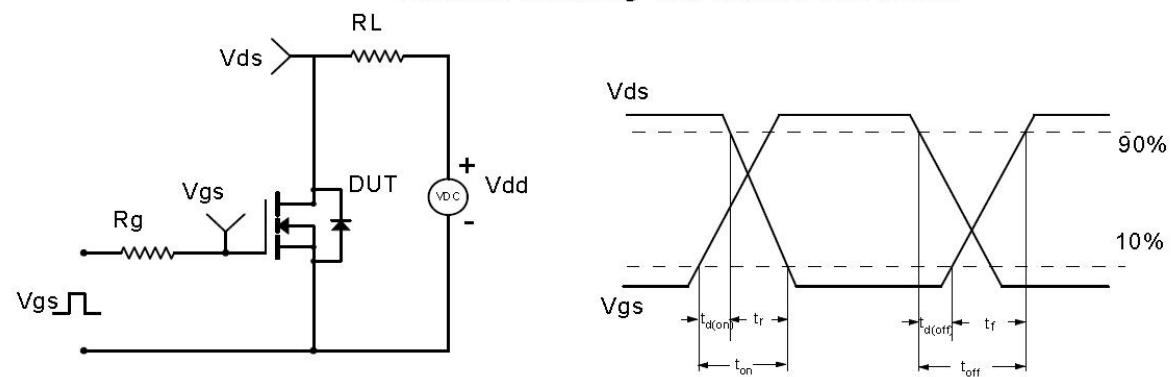


## Test Circuit & Waveform

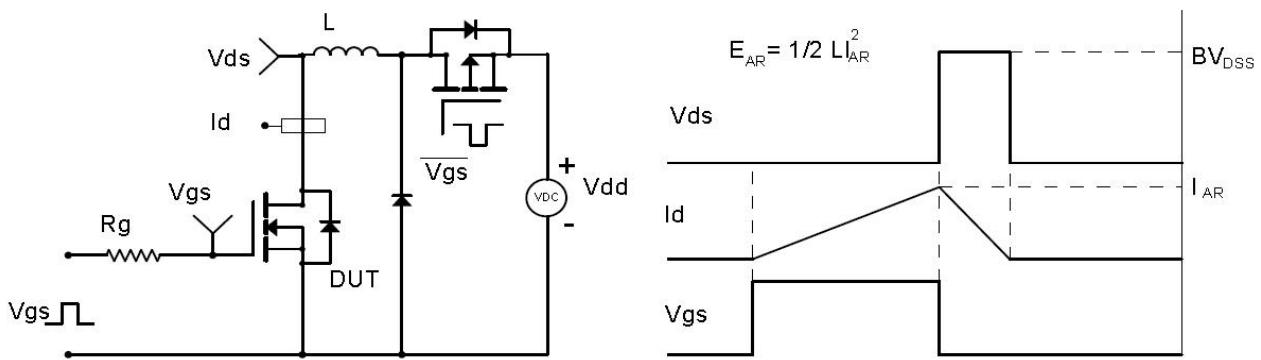
Gate Charge Test Circuit & Waveform



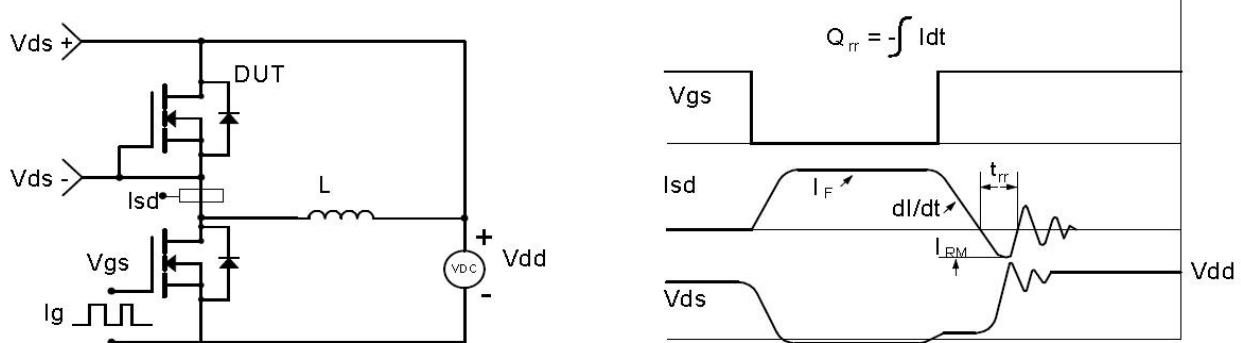
Resistive Switching Test Circuit & Waveforms

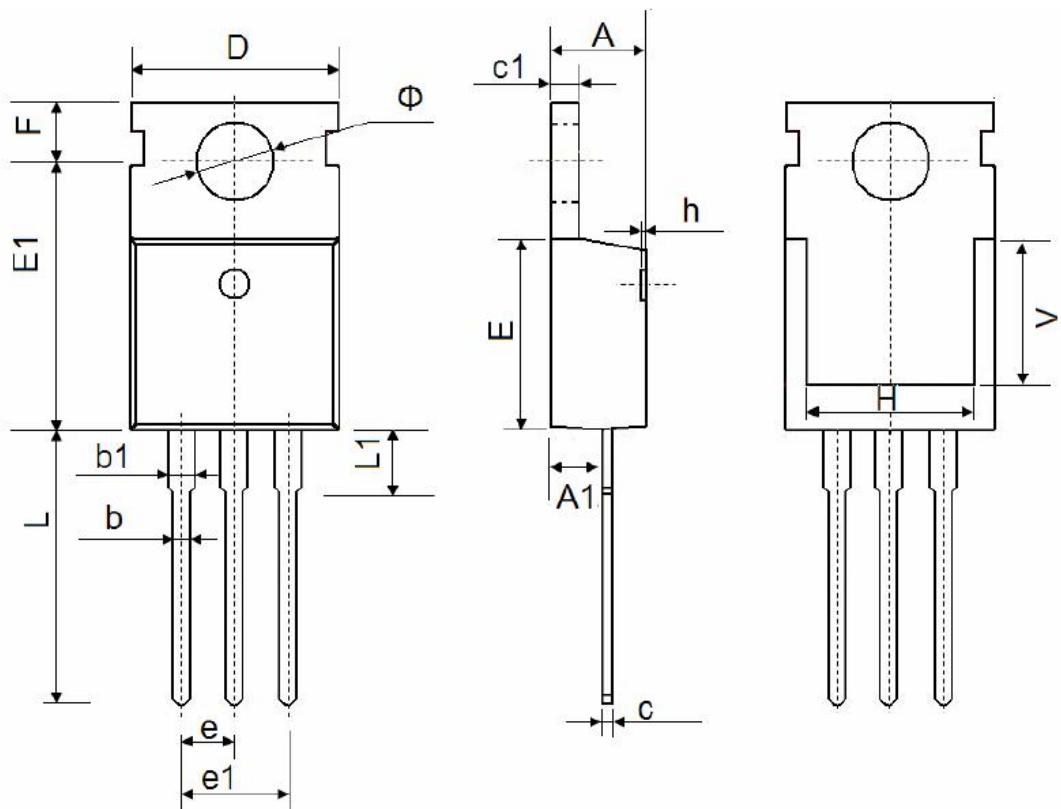


Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



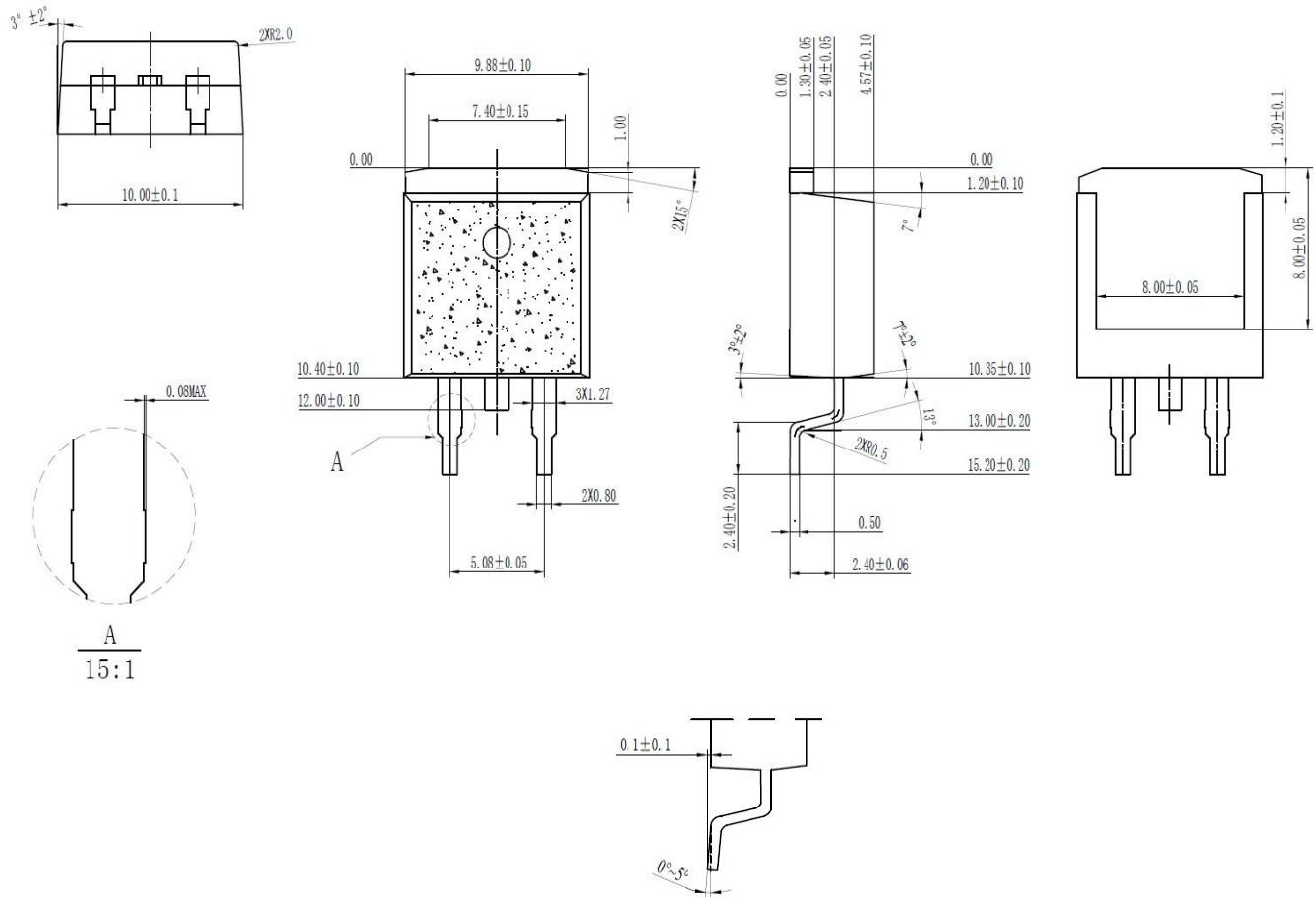
Diode Recovery Test Circuit & Waveforms



**Package Outline: TO-220-3L**

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.9500	9.750	0.352	0.384
E1	12.650	12.950	0.498	0.510
e	2.540 Typ.		0.100 Typ.	
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
H	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	7.500 Ref.		0.295 Ref.	
Φ	3.400	3.800	0.134	0.150

**Package Outline: TO-263-2L**



**技术要求:**

1. 塑封体中心与引线框架中心线偏差≤0.05，  
上下塑封体中心偏差≤0.05；
2. 塑封体不准有缺损、气泡、气孔、裂纹等缺陷；
3. 塑封体表面除阴影部分为毛面，其余为光面；
4. 未注脱模斜度≤5°；
5. 未注公差为±0.05，未注圆角为R0.15 (max)。

**Revision History**

Revision	Date	Major changes
0.0	2020/9/18	Preliminary Revision
1.0	2020/12/10	Official version